

Search Notes

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Examiner

Chau Nguyen

Applicant(s)/Patent under
Reexamination

TERUUCHI ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	513	12/15/2004	CN
715	514	12/17/2004	CN
715	531	12/17/2004	CN
713	176	12/15/2004	CN
713	179	12/15/2004	CN
713	180	12/15/2004	CN
713	189	12/15/2004	CN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Reports	12/15/2004	CN
	12/16/2004	CN
	12/17/2004	CN
Updated Search on East Reports	8/23/2005	CN
Updated Search on East Reports	02/07/2006	CN
	2/8/2006	CN
	2/9/2006	CN
NPL Search on IEEE Database	2/9/2006	CN